

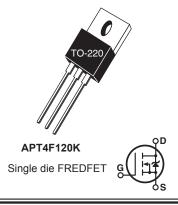


APT4F120K

1200V, 4A, 4.2Ω Max Trr ≤195nS

N-Channel FREDFET

Power MOS 8[™] is a high speed, high voltage N-channel switch-mode power MOSFET. This 'FREDFET' version has a drain-source (body) diode that has been optimized for high reliability in ZVS phase shifted bridge and other circuits through reduced trr, soft www.Datafrecovery, and high recovery dv/dt capability. Low gate charge, high gain, and a greatly reduced ratio of C_{rss}/C_{iss} result in excellent noise immunity and low switching loss. The intrinsic gate resistance and capacitance of the poly-silicon gate structure help control di/dt during switching, resulting in low EMI and reliable paralleling, even when switching at very high frequency.



FEATURES

- · Fast switching with low EMI
- · Low trr for high reliability
- Ultra low C_{rss} for improved noise immunity
- · Low gate charge
- · Avalanche energy rated
- RoHS compliant *J*

TYPICAL APPLICATIONS

- · ZVS phase shifted and other full bridge
- · Half bridge
- · PFC and other boost converter
- Buck converter
- · Single and two switch forward
- Flyback

Absolute Maximum Ratings

Symbol	Parameter	Ratings	Unit
	Continuous Drain Current @ T _c = 25°C	4	
I _D	Continuous Drain Current @ T _c = 100°C	3	А
I _{DM}	Pulsed Drain Current ^①	15	
V _{GS}	Gate - Source Voltage	±30	V
E _{AS}	Single Pulse Avalanche Energy [®]	310	mJ
I _{AR}	Avalanche Current, Repetitive or Non-Repetitive	2	А

Thermal and Mechanical Characteristics

Symbol	Characteristic		Тур	Мах	Unit	
P _D	Total Power Dissipation @ $T_c = 25^{\circ}C$		-	225	W	
R _{ejc}	Junction to Case Thermal Resistance	-	-	.56	°C/W	
$R_{_{ ext{ heta} ext{ iny CS}}}$	Case to Sink Thermal Resistance, Flat, Greased Surface	-	.11	-		
Τ _J , Τ _{stg}	Operating and Storage Junction Temperature Range	-55	-	150	°C	
Τ _L	Soldering Temperature for 10 Seconds (1.6mm from case)	-	-	300		
10/	W _T Package Weight	-	0.07	-	oz	
vv _T		-	1.22	-	g	
Torque	Mounting Torque (TO-220 Package), 4-40 or M3 screw	-	-	10	in·lbf	
		-	-	1.1	N∙m	

Microsemi Website - http://www.microsemi.com

Static Characteristics

T_J = 25°C unless otherwise specified

APT4F120K

Symbol	Parameter	Test Conditions	Min	Тур	Мах	Unit
V _{BR(DSS)}	Drain-Source Breakdown Voltage	$V_{_{\rm GS}}$ = 0V, I_{_{\rm D}} = 250µA	1200			V
$\Delta V_{BR(DSS)} / \Delta T_{J}$	Breakdown Voltage Temperature Coefficient	Reference to 25°C, I_{D} = 250µA		1.41		V/°C
R _{DS(on)}	Drain-Source On Resistance ©	V _{GS} = 10V, I _D = 2A		3.42	4.2	Ω
V _{GS(th)}	Gate-Source Threshold Voltage		2.5	4	5	V
$\Delta V_{GS(th)} / \Delta T_J$	Threshold Voltage Temperature Coefficient	$V_{GS} = V_{DS}, I_{D} = 0.5 \text{mA}$		-10		mV/°C
	Zero Gate Voltage Drain Current	V _{DS} = 1200V T _J = 25°C			250	
DSS		$V_{GS} = 0V$ $T_J = 125^{\circ}C$			1000	μA
I _{GSS}	Gate-Source Leakage Current	$V_{GS} = \pm 30V$			±100	nA

Dynamic Characteristics

T_J = 25°C unless otherwise specified

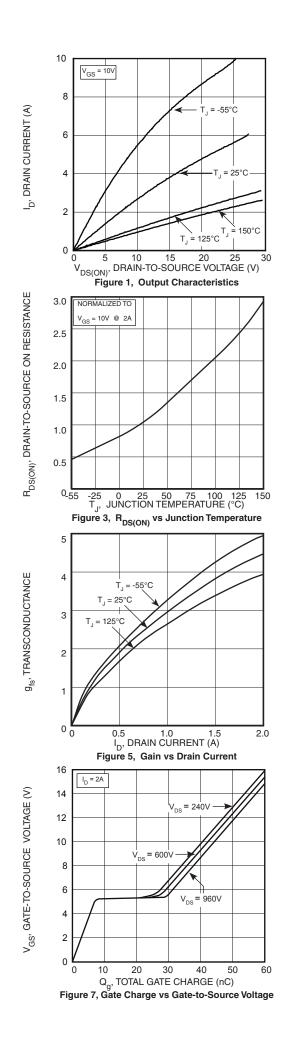
Symbol	Parameter	Test Conditions	Min	Тур	Мах	Unit
9 _{fs}	Forward Transconductance	V _{DS} = 50V, I _D = 2A		4.5		S
C _{iss}	Input Capacitance			1385		
C _{rss}	Reverse Transfer Capacitance	V _{GS} = 0V, V _{DS} = 25V f = 1MHz		17		
C _{oss}	Output Capacitance			100		рF
C _{o(cr)} ④	Effective Output Capacitance, Charge Related	$\lambda = 0 \lambda \lambda = 0 \lambda to 200 \lambda$		40		
C _{o(er)} ⑤	Effective Output Capacitance, Energy Related	$V_{GS} = 0V, V_{DS} = 0V \text{ to } 800V$		20		
Q _g	Total Gate Charge			43		
Q _{gs}	Gate-Source Charge	$V_{GS} = 0 \text{ to } 10V, I_{D} = 2A,$ $V_{DS} = 600V$		7		nC
Q _{gd}	Gate-Drain Charge	V _{DS} = 000V		20		
t _{d(on)}	Turn-On Delay Time			7.4		
t _r	Current Rise Time	Resistive Switching		4.4		
t _{d(off)}	Turn-Off Delay Time	$V_{DD} = 800V, I_{D} = 2A$ $R_{G} = 10\Omega \text{ (6)}, V_{GG} = 15V$		24		ns
t _r	Current Fall Time	1012 C, V _{GG} - 10V		6.9		

Source-Drain Diode Characteristics

Symbol	Parameter	Test Conditions		Min	Тур	Мах	Unit
۱ _s	Continuous Source Current (Body Diode)	MOSFET symbol showing the integral reverse p-n junction diode (body diode)	OD D			4	А
I _{SM}	Pulsed Source Current (Body Diode) ^①		SU III			15	A
$V_{\rm SD}$	Diode Forward Voltage	$I_{SD} = 2A, T_{J} = 25^{\circ}C, V_{GS} = 0V$			0.8	1.3	V
4	Reverse Recovery Time Reverse Recovery Charge	I _{SD} = 2A ^③ , di _{SD} /dt = 100A/μs, V _{DD} = 100V	T _J = 25°C		170	195	20
t _{rr}			T _J = 125°C		330	400	nS
0			T _J = 25°C	ĺ	.370		
Q _{rr}			T _J = 125°C		.820		μC
	Reverse Recovery Current		T _J = 25°C		4.90		
I _{rrm}			T _J = 125°C		5.40		A
dv/dt	Peak Recovery dv/dt	I _{SD} ≤2A, di/dt≤1000Aµs, V _{DD} = 800V, T _J =125°C				20	V/ns

Repetitive Rating: Pulse width and case temperature limited by maximum junction temperature.
Starting at T_J = 25°C, L = 155.0mH, R_G = 25Ω, I_{AS} = 2A.
Pulse test: Pulse Width < 380µs, duty cycle < 2%.
C_{o(cr)} is defined as a fixed capacitance with the same stored charge as C_{OSS} with V_{DS} = 67% of V_{(BR)DSS}.
C_{o(cr)} is defined as a fixed capacitance with the same stored energy as C_{OSS} with V_{DS} = 67% of V_{(BR)DSS}. To calculate C_{o(er)} for any value of V_{DS} less than V_{(BR)DSS}, use this equation: C_{o(er)} = -8.32E-8/V_{DS}⁴2 + 3.49E-8/V_{DS} + 1.30E-10.
R_G is external gate resistance, not including internal gate resistance or gate driver impedance. (MIC4452)

Microsemi reserves the right to change, without notice, the specifications and information contained herein.



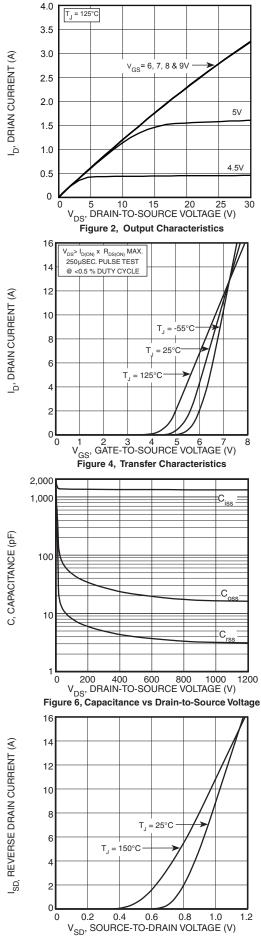
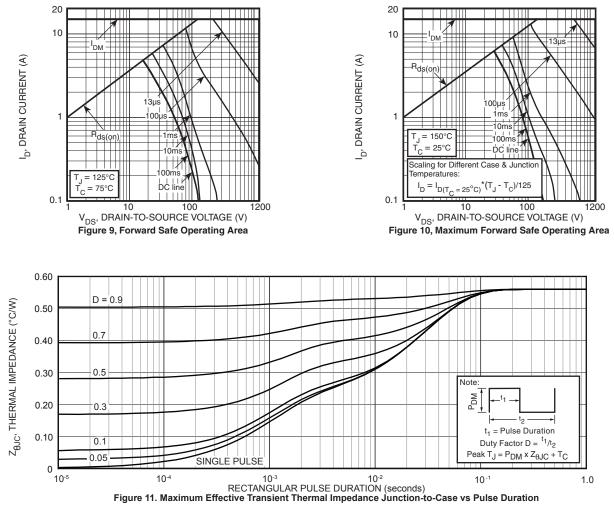


Figure 8, Reverse Drain Current vs Source-to-Drain Voltage



TO-220 (K) Package Outline e3 100% Sn Plated

10.66 (.420) 9.66 (.380) 1.39 (.055) 0.51 (.020) 5.33 (.210) 4.83 (.190) Drain 6.85[°](.270) 5.85 (.230) ▲ ٨ 4.08 (.161) Dia. 3.54 (.139) 3.42 (.135) 2.54 (.100) 16.25 (.639) 14.23 (.560) 3.683 (.145) MAX 14.73 (.580) 12.70 (.500) Gate 0.50 (.020) 0.41 (.016) Drain Source 2.92 (.115) 2.04 (.080) 1.01 (.040) 3-Plcs. 0.83 (.033) 1.77 (.070) 3-Plcs. 1.15 (.045) 2.79 (.110) 2.29 (.090) 4.82 (.190) 3.56 (.140) 5.33 (.210) 4.83 (.190)

Dimensions in Millimeters and (Inches)

Microsemi's products are covered by one or more of U.S. patents 4,895,810 5,045,903 5,089,434 5,182,234 5,019,522 5,262,336 6,503,786 5,256,583 4,748,103 5,283,202 5,231,474 5,434,095 5,528,058 6,939,743 7,352,045 5,283,201 5,801,417 5,648,283 7,196,634 6,664,594 7,157,886 6,939,743 7,342,262 and foreign patents. US and Foreign patents pending. All Rights Reserved.